

ZXTN19100CG 100V NPN low sat medium power transistor in SOT223

Summary

$$\begin{split} & {\sf BV}_{\sf CEX} > 200{\sf V} \\ & {\sf BV}_{\sf CEO} > 100{\sf V} \\ & {\sf BV}_{\sf ECO} > 5{\sf V} \\ & {\sf I}_{\sf C(cont)} = 5.5{\sf A} \\ & {\sf V}_{\sf CE(sat)} < 65{\sf mV} @ \ 1{\sf A} \\ & {\sf R}_{\sf CE(sat)} = 43{\sf m}\Omega \\ & {\sf P}_{\sf D} = 3.0{\sf W} \end{split}$$



Complementary part number ZXTP19100CG

Description

Packaged in the SOT223 outline this new low saturation NPN transistor offers extremely low on state losses making it ideal for use in DC-DC circuits and various driving and power management functions.

Features

- Higher power dissipation SOT223 package
- High peak current
- Low saturation voltage
- Highforward blocking voltage

Applications

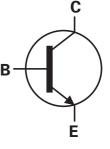
- PSU start up switch
- Motor drive
- Lamp, relay and solenoid drive

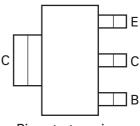
Ordering information

Device	Reel size	Tape width	Quantity
	(inches)	(mm)	per reel
ZXTN19100CGTA	7	12	1000

Device marking

ZXTN19 100C





Pinout - top view

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Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-Base voltage	V _{CBO}	200	V
Collector-Emitter voltage (forward blocking)	V _{CEX}	200	V
Collector-Emitter voltage	V _{CEO}	100	V
Emitter-Collector voltage (reverse blocking)	V _{ECX}	6	V
Emitter-Base voltage	V _{EBO}	7	V
Continuous Collector current ^(c)	۱ _C	5.5	А
Base current	Ι _Β	1	А
Peak pulse current	I _{CM}	10	А
Power dissipation at $T_A = 25^{\circ}C^{(a)}$	PD	1.2	W
Linear derating factor		9.6	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(b)}$	PD	1.6	W
Linear derating factor		12.8	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(c)}$	PD	3.0	W
Linear derating factor		24	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(d)}$	PD	5.3	W
Linear derating factor		42	mW/°C
Power dissipation at $T_{C} = 25^{\circ}C^{(e)}$	PD	10.2	W
Linear derating factor		81	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient ^(a)	R _{OJA}	104	°C/W
Junction to ambient ^(b)	R _{OJA}	78	°C/W
Junction to ambient ^(c)	R _{OJA}	42	°C/W
Junction to ambient ^(d)	R _{OJA}	23.5	°C/W
Junction to case ^(e)	R _{OJC}	12.3	°C/W

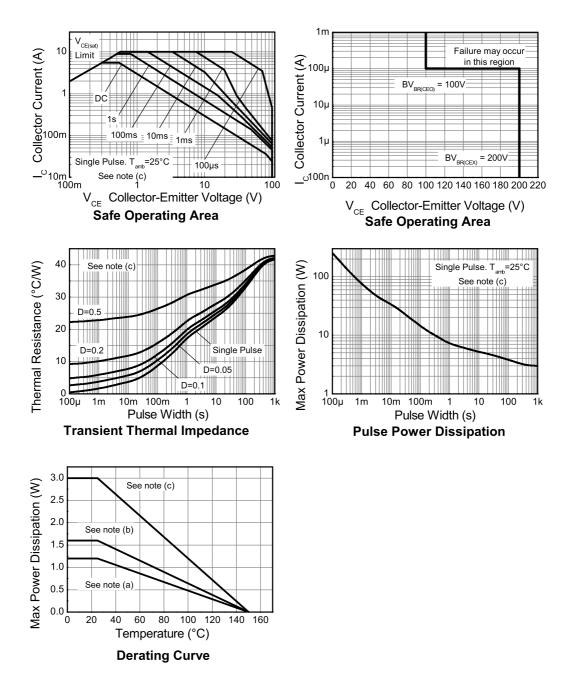
NOTES:

(a) For a device surface mounted on 15mm x 15mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

(b) Mounted on 25mm x 25mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions. (c) Mounted on 50mm x 50mm x 0.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions. (d) As (c) above measured at t<5seconds.

(e) Junction to case (collector tab). Typical.

Thermal characteristics



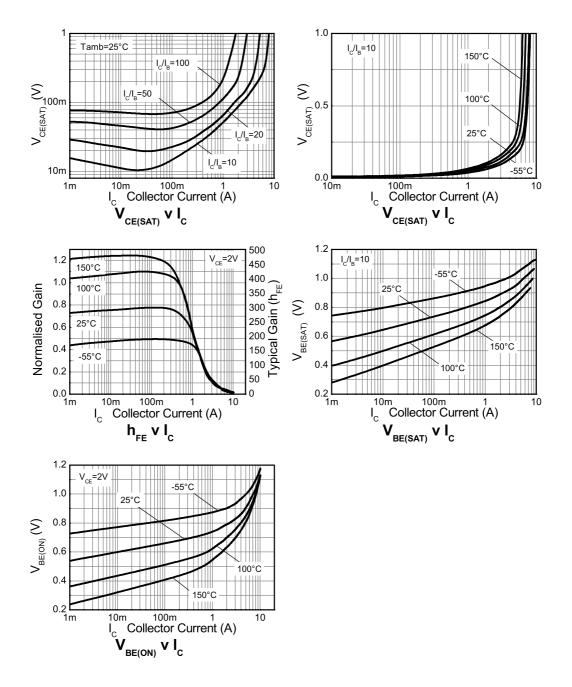
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-Base breakdown Voltage	BV _{CBO}	200	240		V	I _C = 100μA
Collector-Emitter breakdown voltage (forward blocking)	BV _{CEX}	200	240		V	$I_{C} = 100 \mu A, R_{BE} < 1 k \Omega$ or $-1 V < V_{BE} < 0.25 V$
Collector-Emitter breakdown voltage	BV _{CEO}	100	120		V	I _C = 10mA ^(*)
Emitter-Collector breakdown voltage (reverse blocking)	BV _{ECX}	6	8.3		V	$I_{E} = 100 \mu A, R_{BC} < 1 k \Omega$ or $0.25 V > V_{BC} > -0.25 V$
Emitter-Collector breakdown voltage (reverse blocking)	BV _{ECO}	5	8		V	I _E = 100μA
Emitter-Base breakdown voltage	BV _{EBO}	7	8.3		V	I _E = 100μA
Collector-Base cut-off current	I _{CBO}		<1	50 0.5	nA μA	V _{CB} = 200V V _{CB} = 200V, T _{amb} = 100°C
Collector-Emitter cut-off current	I _{CEX}			100	nA	V_{CE} = 200V, R_{BE} < 1k Ω or -1V < V _{BE} < 0.25V
Emitter cut-off current	I _{EBO}		<1	50	nA	V _{EB} = 5.6V
Collector-Emitter	V _{CE(sat)}		50	65	mV	I _C = 1A, I _B = 100mA ^(*)
saturation voltage			110 245	140 430	mV mV	$I_{C} = 1A, I_{B} = 20mA^{(*)}$ $I_{C} = 5.5A, I_{B} = 550mA^{(*)}$
Base-Emitter saturation voltage	V _{BE(sat)}		1005	1100	mV	$I_{\rm C} = 5.5 {\rm A}, I_{\rm B} = 550 {\rm m} {\rm A}^{(*)}$
Base-Emitter turn-on voltage	V _{BE(on)}		950	1050	mV	$I_{C} = 5.5A, V_{CE} = 2V^{(*)}$
Static forward current transfer ratio	h _{FE}	200 130	300 190 25	500		$\begin{split} I_{C} &= 100 \text{mA}, V_{CE} = 2 \text{V}^{(*)} \\ I_{C} &= 1\text{A}, V_{CE} = 2 \text{V}^{(*)} \\ I_{C} &= 5.5\text{A}, V_{CE} = 2 \text{V}^{(*)} \end{split}$
Transition frequency	f _T		150		MHz	I _C = 50mA, V _{CE} = 10V f = 100MHz
Input capacitance	C _{ibo}		305	400	pF	V _{EB} = 0.5V, f = 1MHz ^(*)
Output capacitance	C _{obo}		15.7	25	pF	V _{CB} = 10V, f = 1MHz ^(*)
Delay Time	t _(d)		28.3		ns	
Rise time	t _(r)		23.6		ns	I _C = 500mA, V _{CC} = 10V,
Storage time	t _(s)		962		ns	l _{B1} = -l _{B2} = 50mA
Fall time	t _(f)		133		ns]

Electrical characteristics (at T_{amb} = 25°C unless otherwise stated).

NOTES:

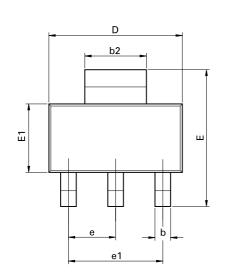
(*) Measured under pulsed conditions. Pulse width \leq 300µs; duty cycle \leq 2%.

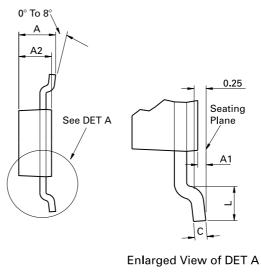
Typical characteristics



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Package outline - SOT223





Conforms to JEDEC TO-261 AA Issue B

Dim.	Millin	neters	Inc	hes	Dim.	Millimeters		Inches	
Dini.	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	-	1.80	-	0.071	D	6.30	6.70	0.248	0.264
A1	0.02	0.10	0.0008	0.004	е	2.30 BSC		0.0905 BSC	
A2	1.55	1.65	0.0610	0.0649	e1	4.60 BSC		0.181 BSC	
b	0.66	0.84	0.026	0.033	E	6.70	7.30	0.264	0.287
b2	2.90	3.10	0.114	0.122	E1	3.30	3.70	0.130	0.146
С	0.23	0.33	0.009	0.013	L	0.90	-	0.355	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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